

<b>Notice of References Cited</b>	Application/Control No. 10/673,041	Applicant(s)/Patent Under Reexamination SOHIER ET AL.	
	Examiner Tae H. Yoon	Art Unit 1714	Page 1 of 1

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*	C	US-2003/0206928 A1	11-2003	TORMALA et al.	424/400
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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